

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 248760US0RDCONT		SERIAL NO. New Continuation of 107188,744 107973,297	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yasuo OHBA			
				FILING DATE Herein 2-9-04		GROUP 2822	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>100</i>	AA	5,228,044	07/13/93	OHBA	372	4501	
	AB	5,235,194	08/10/93	IZUMIYA, et al.	257	13	
	AC	5,273,933	12/28/93	HATANO, et al.	117	09	
	AD	5,317,167	05/31/94	IZUMIYA, et al.	257	13	
	AE	5,432,808	07/11/95	HATANO, et al.	372	4501	
	AF	5,617,438	04/01/97	HATANO, et al.	372	4501	
	AG	5,740,192	04/14/98	HATANO, et al.	372	4501	
	AH	5,998,810	12/07/99	HATANO, et al.	257	102	
	AI	6,242,764	08/05/01	Y. OHBA, et al.	257	190	
	AJ	5,890,485	11/23/99	Y. OHBA	257	94	
	AK	5,656,832	<i>8/97</i> 06/04/99	Y. OHBA, et al.	257	190	
	AL	5,909,040	06/01/99	Y. OHBA, et al.	257	190	
<i>100</i>	AM	5,929,466	07/27/99	Y. OHBA, et al.	257	103	
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>John M. Seward</i>					<input type="checkbox"/> Additional References sheet(s) attached Date Considered <i>7/24/06</i>		
<small>*Examiner's Initial If reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

*REM
4/12/06*